Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,149	VALDEZ, JUAN F.	
Examiner	Art Unit	
David Dunn	3616	

SEARCHED			
Class	Subclass	Date	Examiner
280	784 782 7928	11/10/2005	DD
296	187.06		
	187.03		
			·

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			×
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search; see enclosed	11/10/2005	DD